Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/808,287	KAMADA ET AL.	
Examiner	Art Unit	

2181

Chun-Kuan (Mike) Lee

	SEAR	CHED	
Class	Subclass	Date	Examiner
710	22-28	3/30/2007	CHUN- KUAN Lee
710	48-50	3/30/2007	

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710	22-28	3/30/2007	CHUN- KUAN Lee
710	48-50	3/30/2007	
710	52	3/30/2007	
710	57	3/30/2007	
710	60	3/30/2007	
710	260-262	3/30/2007	V'

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
(EAST) US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB Inventor search on PALM and eDAN	3/30/2007	CHUNT KUAN hee	
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